In re Patent Application of: VINSON ET AL.

Serial No. 10/696,918

Filing Date: October 30, 2003

In the Claims:

Claims 1-9 (CANCELLED)

- 10. (CURRENTLY AMENDED) An integrated circuit chip module comprising:
 - a substrate;
- an integrated circuit die mounted on the substrate and having die pads and an exposed surface opposite from the substrate;
- a plurality of substrate bonding pads positioned on the substrate adjacent the integrated circuit die; and
- a <u>plurality of</u> decoupling capacitor <u>assembly</u> <u>assemblies</u> mounted on the integrated circuit die, <u>said</u> <u>each</u> decoupling capacitor assembly comprising
 - a capacitor carrier secured onto the exposed surface of the integrated circuit die,
 - a decoupling capacitor carried by said capacitor carrier;
 - a thin film metallization layer positioned on said capacitor carrier; and
 - a conductive adhesive layer engaging said decoupling capacitor and thin film metallization layer and securing said decoupling capacitor to said capacitor carrier;
- a wire bond extending from the thin film metallization layer to a logic pin of the integrated circuit die and from a logic pin to a substrate bonding pad.

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Claim 11 (CANCELLED)

- 12. (CURRENTLY AMENDED) An integrated circuit chip module according to Claim 11 Claim 10, wherein said plurality of decoupling capacitors are mounted in series along said integrated circuit die.
- 13. (ORIGINAL) An integrated circuit chip module according to Claim 10, and further comprising an adhesive securing said decoupling capacitor to said capacitor carrier.
- 14. (ORIGINAL) An integrated circuit chip module according to Claim 10, and further comprising an adhesive securing said decoupling capacitor assembly to said integrated circuit die.
- 15. (ORIGINAL) An integrated circuit chip module according to Claim 10, wherein said capacitor carrier is formed from an aluminum nitride substrate.
- 16. (ORIGINAL) An integrated circuit chip module according to Claim 15, wherein said aluminum nitride substrate ranges in thickness from about 5 mil to about 50 mil.
- 17. (ORIGINAL) An integrated circuit chip module according to Claim 10, wherein a wire bond extends from said capacitor to a logic pin of said integrated circuit die.

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18. (ORIGINAL) An integrated circuit chip module according to Claim 10, and including a bonding pad on said thin film metallization layer for securing a wire bond.

Claims 19-27 (CANCELLED)

28. (CURRENTLY AMENDED) A decoupling capacitor assembly used for decoupling integrated circuit die comprising:

a capacitor carrier formed as an aluminum nitride substrate that is about 5 mil to about 50 mil thickness;

a decoupling capacitor carried by said capacitor carrier;

an adhesive securing said decoupling capacitor to said capacitor carrier; and

a thin film metallization layer formed on the capacitor carrier, wherein said adhesive comprises a conductive adhesive for conducting current between said capacitor and said capacitor carrier; and

a wire bond extending from said decoupling capacitor and adapted to be connected to a logic pin of an integrated circuit die.

Claim 29 (CANCELLED)

30. (CURRENTLY AMENDED) A decoupling capacitor assembly according to Claim 28, and further comprising a bonding pad positioned on said capacitor carrier for connecting a wire the wire bond thereto.

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Claims 31-37 (CANCELLED)

- 38. (CURRENTLY AMENDED) An integrated circuit chip module comprising:
 - a substrate;
- an integrated circuit die mounted on the substrate and having die pads and an exposed surface opposite from the substrate;
- a plurality of substrate bonding pads positioned on the substrate adjacent the integrated circuit die; and
- a <u>plurality of decoupling capacitor assembly assemblies</u> mounted on each integrated circuit die, <u>said each decoupling</u> capacitor assembly comprising
- a capacitor carrier secured onto the exposed surface of the integrated circuit die, and
- a decoupling capacitor carried by the capacitor carrier;
- a wire bond extending from the decoupling capacitor assembly to a die pad and from a die pad to a substrate bonding pad; and
- a wire bond extending from said capacitor carrier to a logic pin of said integrated circuit die.